

<b>Notice of References Cited</b>	Application/Control No. 10/519,410		Applicant(s)/Patent Under Reexamination EGAWA, YOSUKE	
	Examiner Alicia M. Toscano		Art Unit 1796	Page 1 of 1

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	K	US-			
	L	US-			
	M	US-			

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*	N	JP 2001049098 A	02-2001	Japan	OBUCHI et al.	
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**NON-PATENT DOCUMENTS**

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*	U	English translation of JP 2001049098A
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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